Notice of References Cited

| Application/Control No. 10/532,748 | Reexamination | Applicant(s)/Patent Under Reexamination PAVON ET AL. | | |
|------------------------------------|---------------|--|--|--|
| Examiner | Art Unit | | | |
| Kenan Cehic | 2616 | Page 1 of 2 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|----|--|-----------------|-----------------------|----------------|
| * | Α | US-2002/0089994 A1 | 07-2002 | Leach et al. | 370/412 |
| * | В | US-2002/0093929 A1 | 07-2002 | Mangold et al. | 370/336 |
| * | C | US-2003/0063563 A1 | 04-2003 | Kowalski, John M. | 370/230 |
| * | D | US-2003/0081547 A1 | 05-2003 | Ho, Jin-Meng | 370/229 |
| * | E٠ | US-2003/0161340 A1 | 08-2003 | Sherman, Matthew J. | 370/445 |
| * | F | US-2004/0081133 A1 | 04-2004 | Smavatkul et al. | 370/346 |
| * | G | US-2004/0114534 A1 | 06-2004 | Benveniste, Mathilde | 370/252 |
| * | Н | US-2004/0136396 A1 | 07-2004 | Yonge et al. | 370/445 |
| * | 1 | US-2004/0151283 A1 | 08-2004 | Lazoff, David Michael | 379/045 |
| * | 7 | US-2004/0190467 A1 | 09-2004 | Liu et al. | 370/311 |
| * | К | US-2005/0174973 A1 | 08-2005 | Kandala et al. | 370/338 |
| * | L | US-2006/0171362 A1 | 08-2006 | Garg et al. | 370/338 |
| * | М | US-7,123,627 B2 | 10-2006 | Kowalski, John M. | 370/468 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name _. | Classification |
|---|---|--|-----------------|---------|-------------------|----------------|
| | N | | | | | |
| | 0 | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination PAVON ET AL. | Examiner | Art Unit | Page 2 of 2

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|----------------|----------------|
| * | Α | US-2007/0263655 A1 | 11-2007 | Esteves et al. | 370/460 |
| * | В | US-2007/0263657 A1 | 11-2007 | Sugar et al. | 370/465 |
| | C | US- | | | |
| | D | US- | | | |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| 7 | Н | US- | | | |
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| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.